## Atomic force microscopy characterization of polyethylene terephthalate grafting with poly(styrene sulfonate)

Tuan Ngoc Nguyen ${ }^{1}$; Vincent Humblot ${ }^{2}$; Véronique Migonney ${ }^{1 *}$; Raphaël Lévy ${ }^{3 *}$

${ }^{1}$ Laboratory of Chemistry, Structures, Properties of Biomaterials and Therapeutic Agents (CSPBAT), UMR CNRS 7244, Sorbonne Paris Nord University, France
${ }^{2}$ Institut FEMTO-ST UMR CNRS 6174, Université Bourgogne Franche-Comté, 15B Avenue des Montboucons, 25030 Besançon, France
${ }^{3}$ Université Sorbonne Paris Nord and Université de Paris, INSERM, LVTS, F-75018 Paris, France

## Supporting information



Figure S1. XPS spectra of functional PCL and PET: (A) non-grafting PET surface, (B) thermal graft PET surface, (C) UV graft PET surface, and (D) MS graft PET surface


Figure S2: Theoretical estimate of average thickness as a function of $\% \mathrm{~S} / \mathrm{C}$ for a layer of PNaSS on PET. The calculation is based on an estimated depth of PET of 10 nm being probed by XPS (PET $=\left(\mathrm{C}_{10} \mathrm{H}_{8} \mathrm{O}_{4}\right) \mathrm{n} ; \mathrm{PNaSS}=\left(\mathrm{C}_{8} \mathrm{H}_{7} \mathrm{NaO}_{3} \mathrm{~S}\right) \mathrm{n}$; density of PET and PNaSS respectively 1.66 and $\left.2.38 \mathrm{~g} . \mathrm{cm}^{-3}\right)$. The red lines show the experimental results.

The equivalent thickness probed by XPS is estimated to be close to $3 \lambda=10 \mathrm{~nm}$ representing $95 \%$ of the signal, $\lambda$ being the inelastic mean free path of electrons from the PET substrate in the organic PNaSS film; for electrons having a kinetic energy around 1200 eV (from the C1s atomic level), $\lambda$ is estimated to be equal to $3.23 \mathrm{~nm} .{ }^{1}$

The estimated thickness ( $d$ ) of PNaSS on top of PET can then be calculated using the following formula:

$$
\frac{I_{S 2 p}}{I_{C 1 s ~ 284 \mathrm{eV}}}=\frac{\rho_{P N a S S} M_{E T} \sigma_{S 2 p} T_{S 2 p} \lambda_{S 2 p}^{P N a S S}\left(1-\exp \left(\frac{-d}{\lambda_{S 2 p}^{P N a S S} \sin (\theta)}\right)\right)}{\rho_{P E T} M_{N a S S} \sigma_{C 1 s} T_{C 1 s} \lambda_{C 1 S}^{P E T}\left(\frac{-d}{\lambda_{C 1 S}^{P N a S S} \sin (\theta)}\right)}
$$

Wherein: $\theta$ is the photoelectron collection angle. TC1s and TS2p are the relative sensitivity factors of $C$ and $S$, respectively, provided by the spectrometer manufacturer. The Scofield

[^0]photoionization cross-sections $\sigma$ are equal to 1 for $C 1 s$ and 1.44 for $S 2 p .{ }^{2} \lambda x y$ is the inelastic mean free paths of electrons x in the matrix y . They were calculated using the Quases program based on the TPP2M formula 1. $\rho$ PNaSS and $\rho$ PET are the density of PNaSS and PET, respectively. $\mathrm{M}_{\text {Nass }}$ and $\mathrm{M}_{E T}$ are the molecular weight of NaSS (sodium styrene sulfonate) and ET (ethylene terephthalate), respectively.


Figure S3. Contact angle measurement ( $2 \mu \mathrm{~L}, \mathrm{8s}$ ) for non-grafted and modified polyethylene terephthalate (PET)

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Figure S4. SEM images of non-grafted, thermal grafted, thermal grafting in the presence of Mohr's salt, and UV grafted PET; SEM HITACHI TM3000, magnification $\times 20$


Figure S5. AFM image of UV grafted PET with scan size $2 \mu \mathrm{~m} \times 2 \mu \mathrm{~m}, 256$ points/line, scan rate $1 \mathrm{~Hz}, \mathrm{PF}-\mathrm{QNM}$. The fraction of surface area occupied by the low adhesion patches is $8 \%$ (measured with Image J).


Figure S6. 3D AFM images of (a) non-grafted PET, (b) ozonized PET, (c) thermal grafted PET ( tG ), and (d) thermal grafted PET in the presence of Mohr's salt (MSG)


Figure S7. Summarization of AFM images of different PNaSS grafting methods on PET


[^0]:    ${ }^{1}$ Tanuma, S.; Powell, C. J.; Penn, D. R. Calculation of electron inelastic mean free paths (IMFPs) VII. Reliability of the TPP-2M IMFP predictive equation. Surf. Interface Anal. 2003, 35, 268-275.

[^1]:    ${ }^{2}$ Scofield J (1976) Hartree-Slater subshell photoionization cross-sections at 1254 and 1487 eV . J Electron Spectrosc Relat Phenom 8(2):129-37

